

Search Notes

Application/Control No.

10/784,222

Examiner

TAN TRINH

Applicant(s)/Patent under
Reexamination

QIU ET AL.

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
455	504	11/18/2006	TT
	550.1		
	428		
	435.2		
	452.2		
	13.4		
	522		
	524		
	525		
	63.1		
	67.11		
	67.16		
	445		
	114.2		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PG-PUB Text Search (see printout)		11/18/2006	TT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	11/18/2006	TT
Iterference search	11/18/2006	TT